COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

NEW PRODUCT

Product Summary

Device	$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D T_A = +25°C
Q1	25V	4Ω @ V_{GS} = 4.5V	0.4 A
Q2	-30V	80mΩ @ V_{GS}= -12V	-3.2 A
		125mΩ @ V_{GS}= -4.5V	-2.6 A

Description

This new generation MOSFET is designed to minimize the on-state resistance ($R_{DS(ON)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- DC-DC Converters
- Power Management Functions
- Load Switch

Features and Benefits

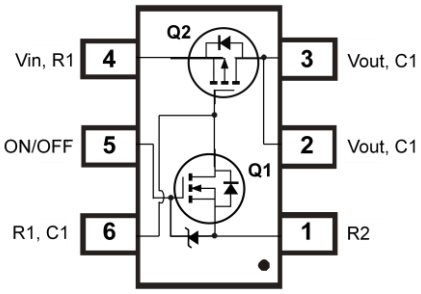
- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- ESD Protected Gate on N-Channel (>6kV Human Body Model)
- **Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)**
- **Halogen and Antimony Free. "Green" Device (Note 3)**
- **Qualified to AEC-Q101 Standards for High Reliability**

Mechanical Data

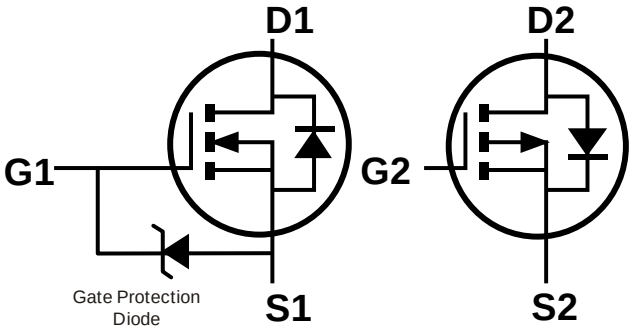
- Case: TSOT26
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram
- Terminals: Finish – Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 e3
- Weight: 0.013 grams (Approximate)

TSOT26

Top View



Top View
Internal Circuit



Q1 N-Channel MOSFET

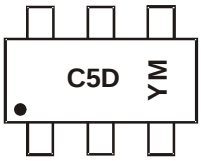
Q2 P-Channel MOSFET

Ordering Information (Note 4)

Part Number	Case	Packaging
DMC25D0UVT-7	TSOT26	3000 / Tape & Reel
DMC25D0UVT-13	TSOT26	10000 / Tape & Reel

Notes:
1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



C5D = Product Type Marking Code
YM or $\overline{Y}$M = Date Code Marking
Y or $\overline{Y}$= Year (ex: C = 2015)
M = Month (ex: 9 = September)

Date Code Key

Year	2015	2016	2017	2018	2019	2020	2021
Code	C	D	E	F	G	H	I

Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	O	N	D

NEW PRODUCT

Maximum Ratings – Q1 (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	25	V
Gate-Source Voltage	V_{GSS}	-0.5 +8	V
Continuous Drain Current (Note 5) V_{GS} = 4.5V	I_D	0.4	A
Maximum Continuous Body Diode Forward Current (Note 6)	I_S	1.2	A
Pulsed Drain Current (Note 6)	I_{DM}	1.5	A

Maximum Ratings – Q2 (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Drain-Source Voltage		V_{DSS}	-30	V
Gate-Source Voltage		V_{GSS}	±12	V
Continuous Drain Current (Note 5) V_{GS} = -10V	Steady State	I_D	-3.2	A
	Note 9		-14.4	A
Continuous Drain Current (Note 5) V_{GS} = -4.5V			-2.6	A
Maximum Continuous Body Diode Forward Current (Note 6)		I_S	-1.2	A
Pulsed Drain Current (Note 6)		I_{DM}	-20	A

Thermal Characteristics

Characteristic		Symbol	Value	Unit
Power Dissipation (Note 5)		P_D	1.2	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	$R_{\theta JA}$	101	°C/W
	Note 9		5	
Thermal Resistance, Junction to Case (Note 5)		$R_{\theta JC}$	37	°C/W
Operating and Storage Temperature Range		T_J, T_{STG}	-55 to +150	°C

Electrical Characteristics – Q1 (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)						
Drain-Source Breakdown Voltage	BV_{DSS}	25	—	—	V	V_{GS} = 0V, I_D = 250µA
Zero Gate Voltage Drain Current	I_{DSS}	—	—	1	µA	V_{DS} = 20V, V_{GS} = 0V
Gate-Source Leakage	I_{GSS}	—	—	100	nA	V_{GS} = 8V, V_{DS} = 0V
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	$V_{GS(TH)}$	0.65	0.85	1.5	V	V_{DS} = V_{GS}, I_D = 250µA
Static Drain-Source On-Resistance	$R_{DS(ON)}$	—	3.8	4	Ω	V_{GS} = 4.5V, I_D = 0.4A
Diode Forward Voltage	V_{SD}	—	0.76	1.2	V	V_{GS} = 0V, I_S = 0.29A
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	C_{iss}	—	26.2	—	pF	V_{DS} = 10V, V_{GS} = 0V, f = 1.0MHz
Output Capacitance	C_{oss}	—	7.1	—		
Reverse Transfer Capacitance	C_{rss}	—	2.7	—		
Gate Resistance	R_g	—	84.5	—	Ω	V_{DS} = 0V, V_{GS} = 0V, f = 1MHz
Total Gate Charge (V_{GS} = 4.5V)	Q_g	—	0.4	—	nC	V_{DS} = 5V, I_D = 0.2A
Total Gate Charge (V_{GS} = 8V)	Q_g	—	0.7	—		
Gate-Source Charge	Q_{gs}	—	0.1	—		
Gate-Drain Charge	Q_{gd}	—	0.1	—		
Turn-On Delay Time	$t_{D(ON)}$	—	3	—	ns	V_{GS} = 4.5V, V_{DS} = 6V, R_G = 50Ω, I_D = 0.5A
Turn-On Rise Time	t_R	—	2.3	—		
Turn-Off Delay Time	$t_{D(OFF)}$	—	7.7	—		
Turn-Off Fall Time	t_F	—	3.7	—		

Notes:
5. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
6. Repetitive rating, pulse width limited by junction temperature.
7. Short duration pulse test used to minimize self-heating effect.
8. Guaranteed by design. Not subject to production testing.
9. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%.

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Electrical Characteristics – Q2 (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 10)						
Drain-Source Breakdown Voltage	BV_{DSS}	-30	—	—	V	V_{GS} = 0V, I_D = -250µA
Zero Gate Voltage Drain Current	I_{DSS}	—	—	-1	µA	V_{DS} = -24V, V_{GS} = 0V
Gate-Source Leakage	I_{GSS}	—	—	±100	nA	V_{GS} = ±12V, V_{DS} = 0V
ON CHARACTERISTICS (Note 10)						
Gate Threshold Voltage	$V_{GS(TH)}$	-0.5	-0.9	-1.5	V	V_{DS} = V_{GS}, I_D = -250µA
Static Drain-Source On-Resistance	$R_{DS(ON)}$	—	59	80	mΩ	V_{GS} = -12V, I_D = -2.3A
		—	75	125		V_{GS} = -4.5V, I_D = -1.9A
		—	—	300		V_{GS} = -2.5V, I_D = -1A
Diode Forward Voltage	V_{SD}	—	-0.7	-1.2	V	V_{GS} = 0V, I_S = -1A
DYNAMIC CHARACTERISTICS (Note 11)						
Input Capacitance	C_{iss}	—	854	—	pF	V_{DS} = -15V, V_{GS} = 0V, f = 1MHz
Output Capacitance	C_{oss}	—	53	—		
Reverse Transfer Capacitance	C_{rss}	—	47	—		
Gate Resistance	R_g	—	11	—	Ω	V_{DS} = 0V, V_{GS} = 0V, f = 1MHz
Total Gate Charge (V_{GS} = -4.5V)	Q_g	—	10	—	nC	V_{DS} = -15V, I_D = -4A
Total Gate Charge (V_{GS} = -10V)	Q_g	—	21	—		
Gate-Source Charge	Q_{gs}	—	1.5	—		
Gate-Drain Charge	Q_{gd}	—	2.8	—		
Turn-On Delay Time	$t_{D(ON)}$	—	3.5	—	ns	V_{GS} = -10V, V_{DS} = -15V, R_G = 6Ω, I_D = -1A
Turn-On Rise Time	t_R	—	3.3	—		
Turn-Off Delay Time	$t_{D(OFF)}$	—	61.4	—		
Turn-Off Fall Time	t_F	—	14.6	—		

Notes: 10. Short duration pulse test used to minimize self-heating effect.
11. Guaranteed by design. Not subject to production testing.

NEW PRODUCT

Typical Characteristics - N-CHANNEL

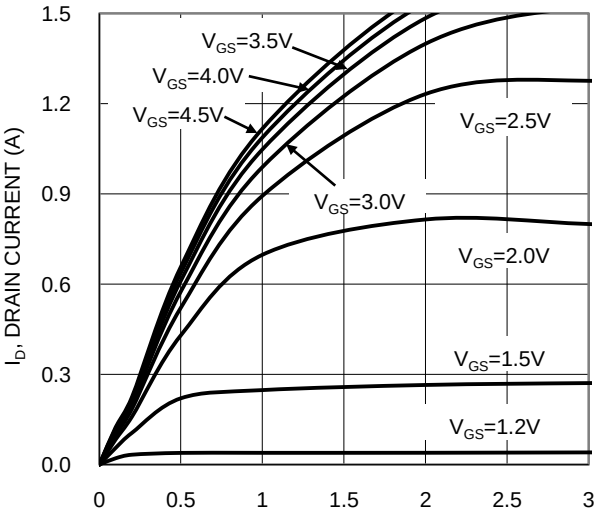

Figure 1. Typical Output Characteristic

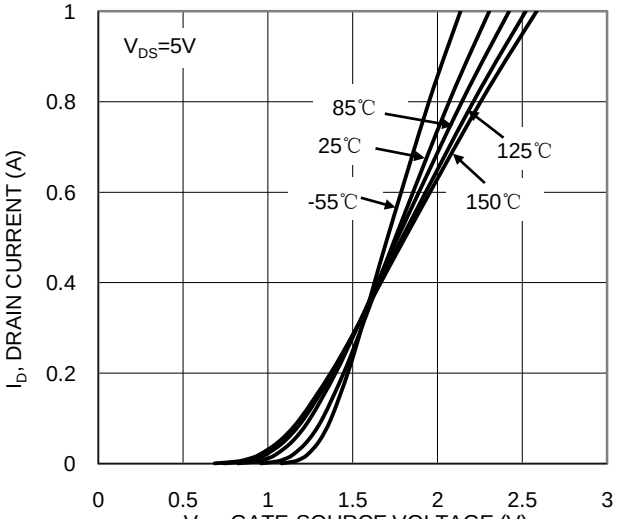

Figure 2. Typical Transfer Characteristic

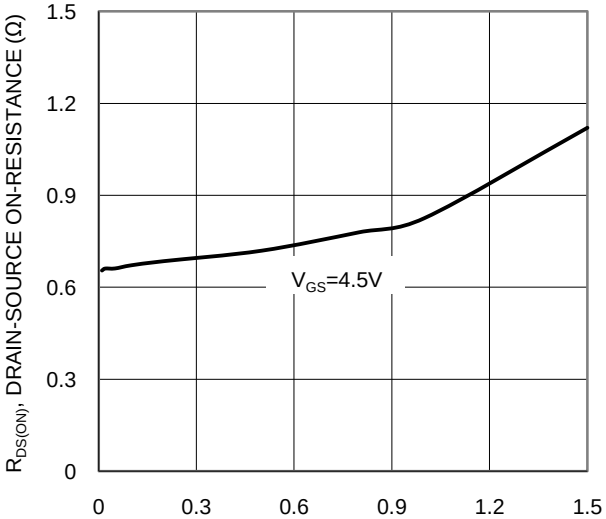

Figure 3. Typical On-Resistance vs Drain Current and Gate Voltage

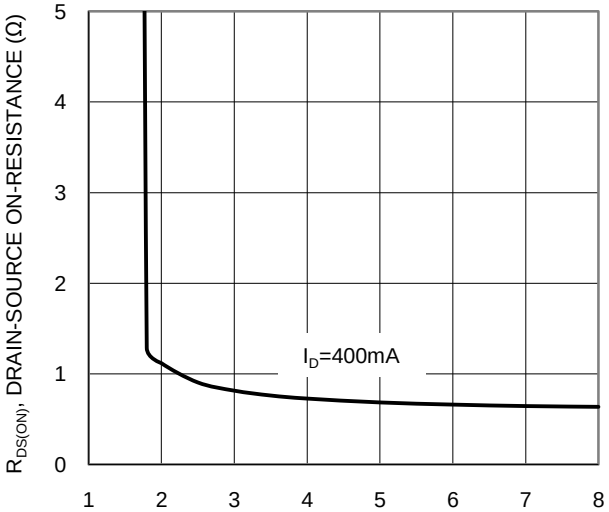

Figure 4. Typical Transfer Characteristic

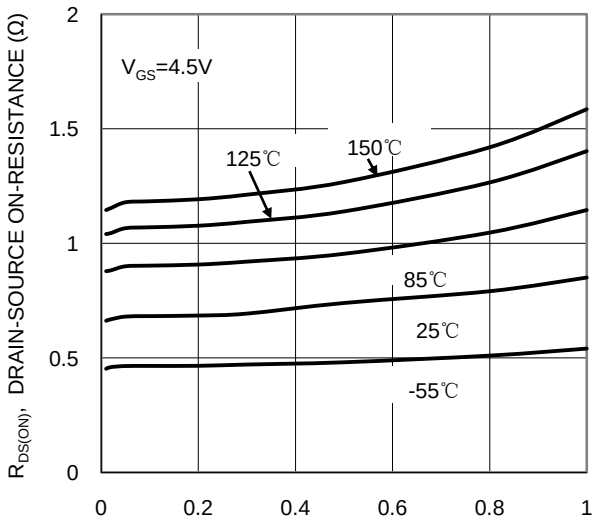

Figure 5. Typical On-Resistance vs Drain Current and Temperature

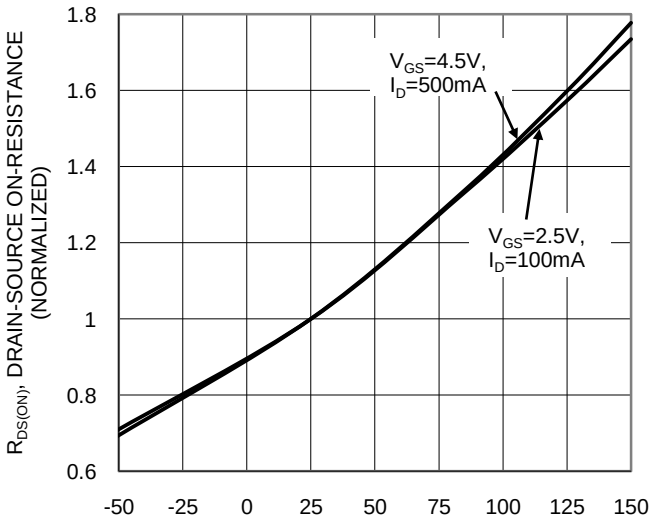

Figure 6. On-Resistance Variation with Temperature

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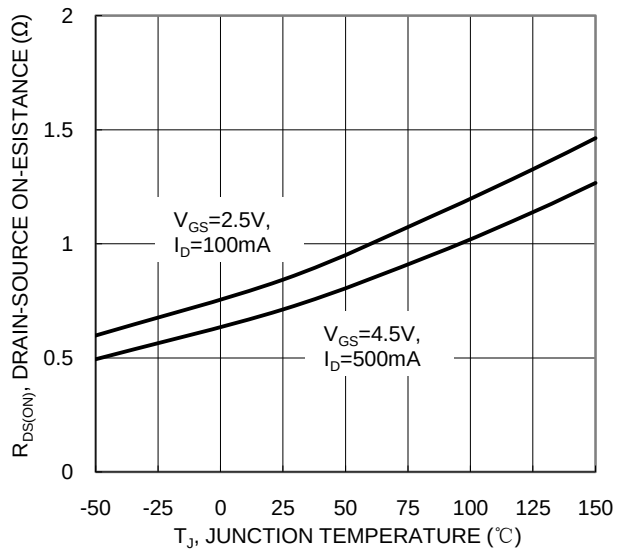

Figure 7. On-Resistance Variation with Temperature

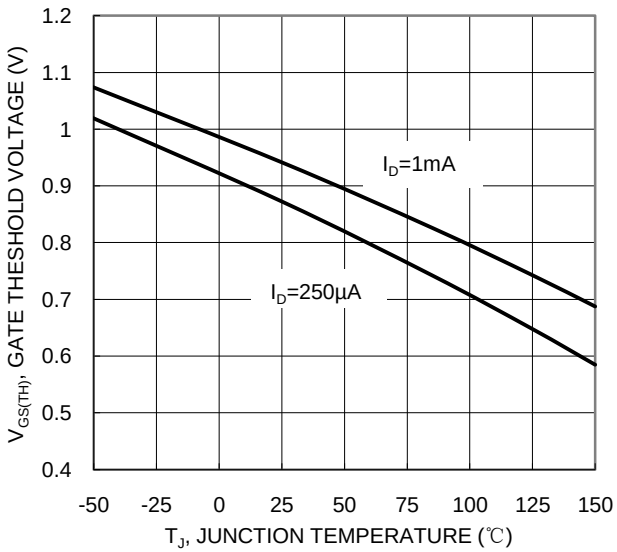

Figure 8. Gate Theshold Variation vs Junction Temperature

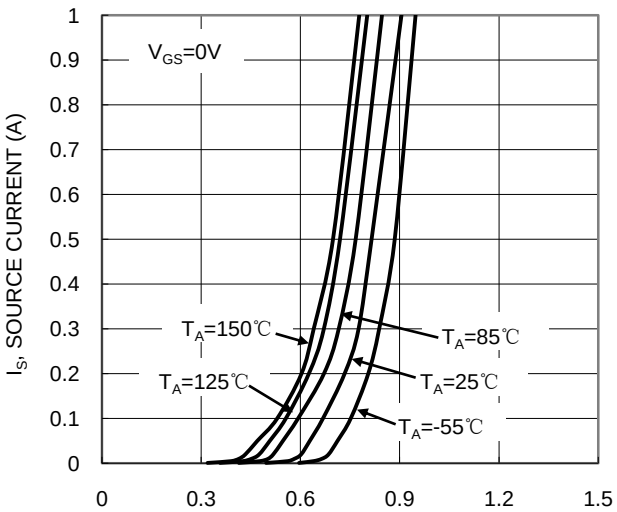

Figure 9. Diode Forward Voltage vs Current

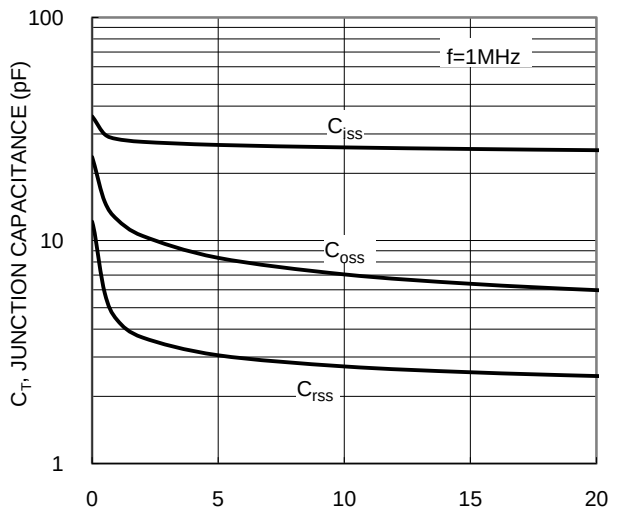

Figure 10. Typical Junction Capacitance

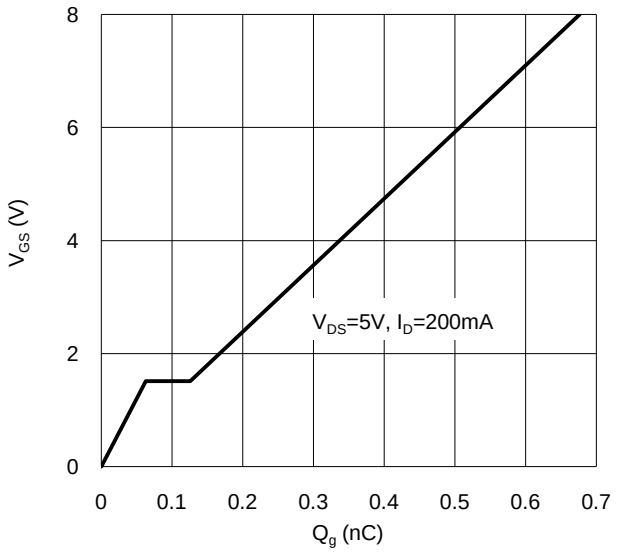

Figure 11. Gate Charge

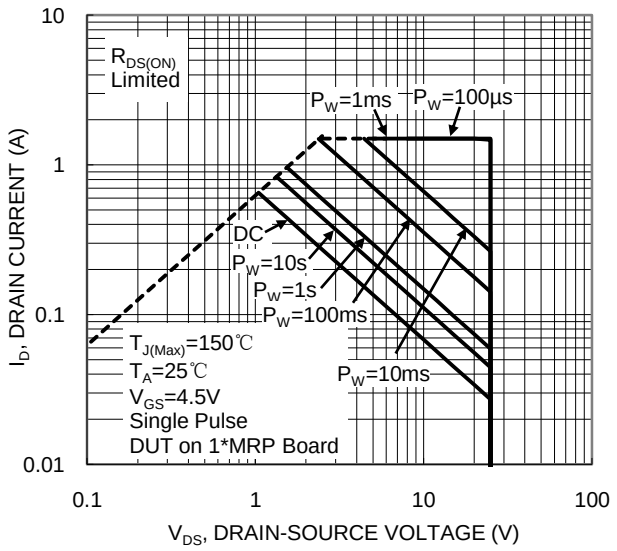

Figure 12. SOA, Safe Operation Area

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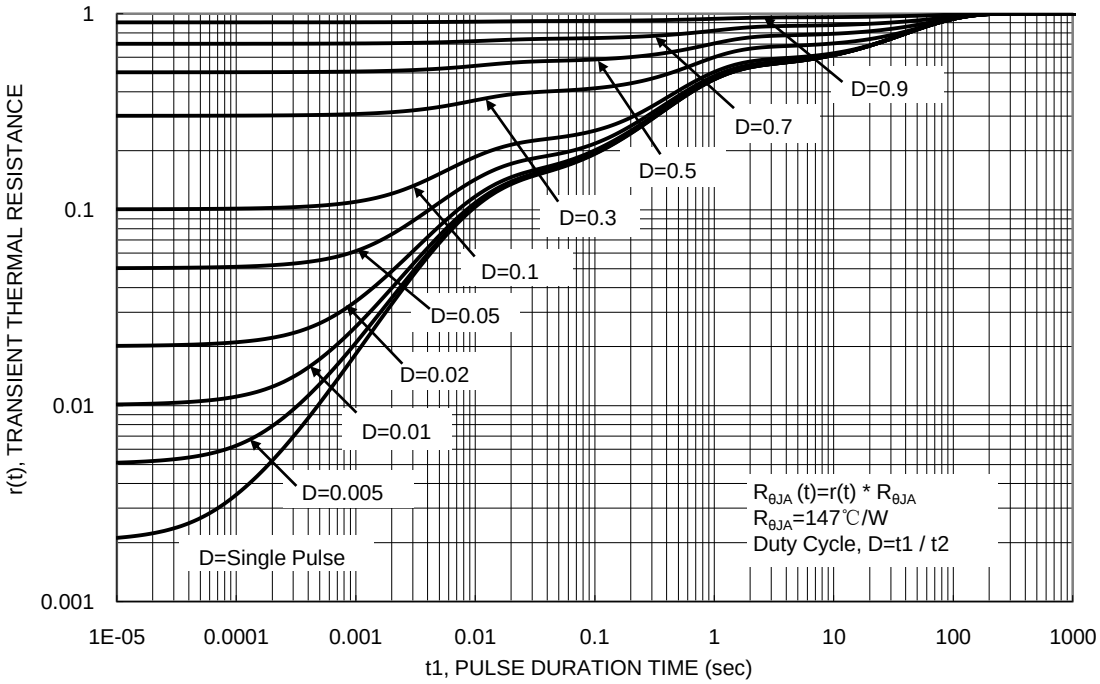

Figure 13. Transient Thermal Resistance

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Typical Characteristics - P-CHANNEL

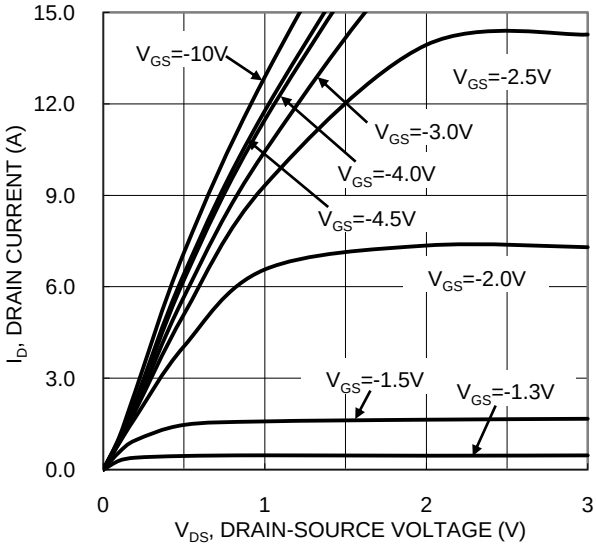

Figure 14. Typical Output Characteristic

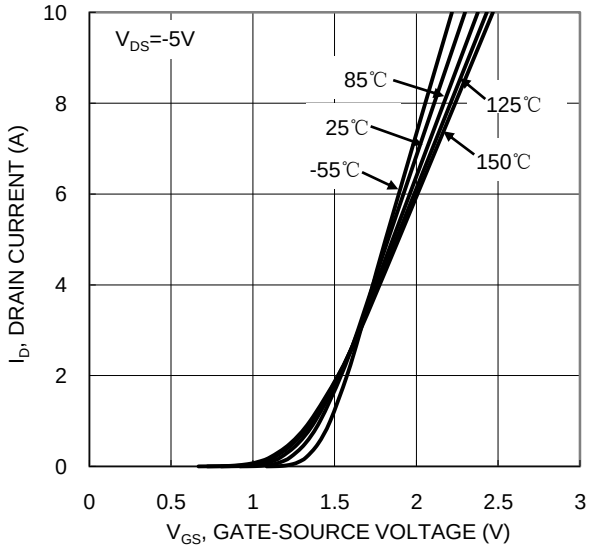

Figure 15. Typical Transfer Characteristic

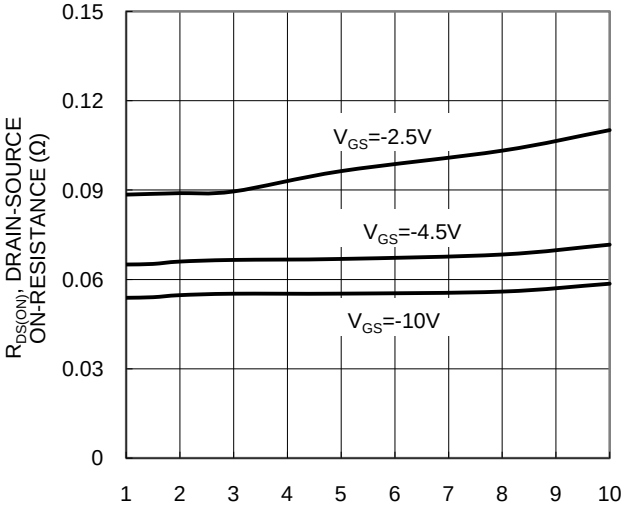

Figure 16. Typical On-Resistance vs Drain Current and Gate Voltage

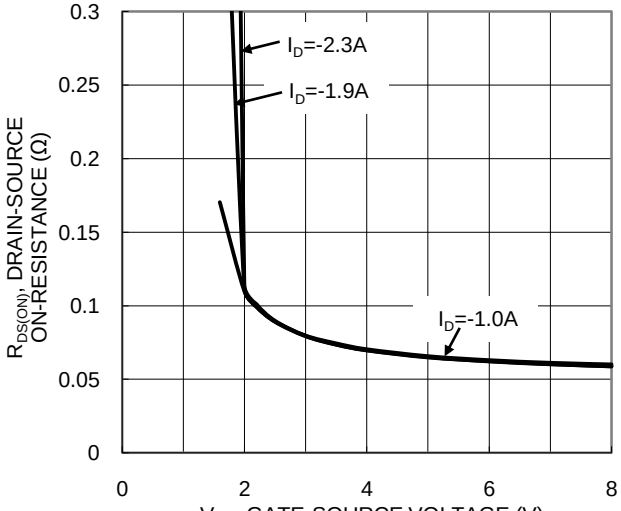

Figure 17. Typical Transfer Characteristic

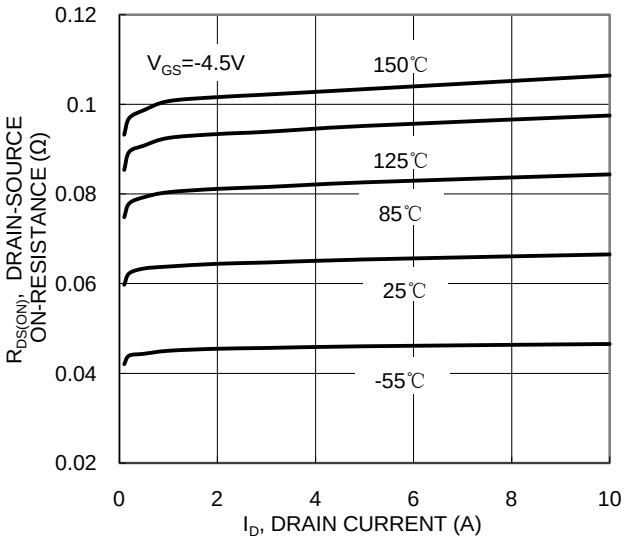

Figure 18. Typical On-Resistance vs Drain Current and Temperature

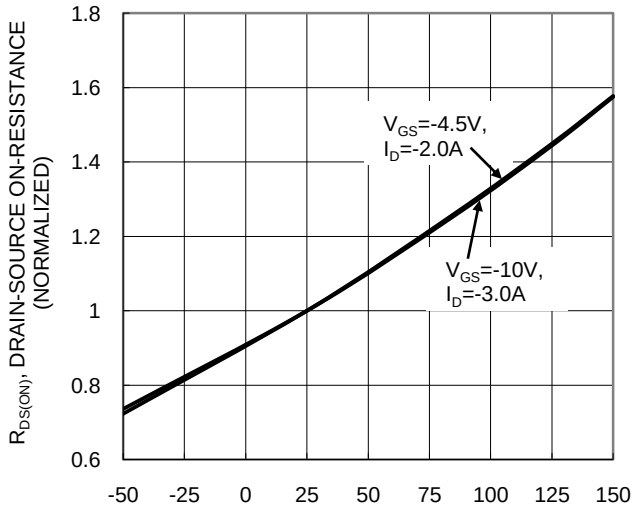

Figure 19. On-Resistance Variation with Temperature

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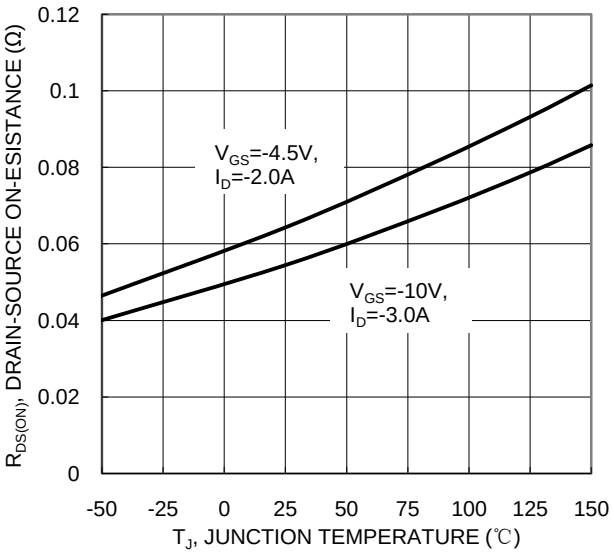


Figure 20. On-Resistance Variation with Temperature

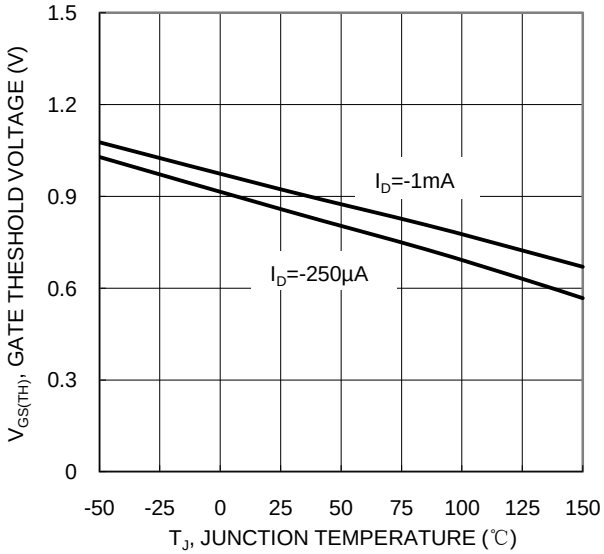


Figure 21. Gate Theshold Variation vs Junction Temperature

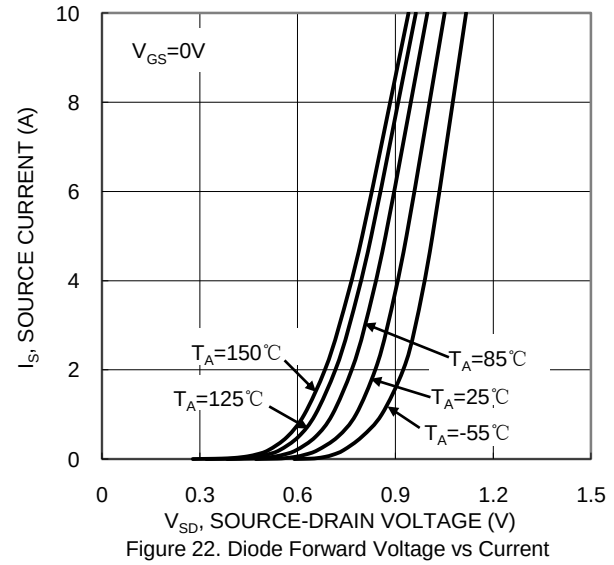
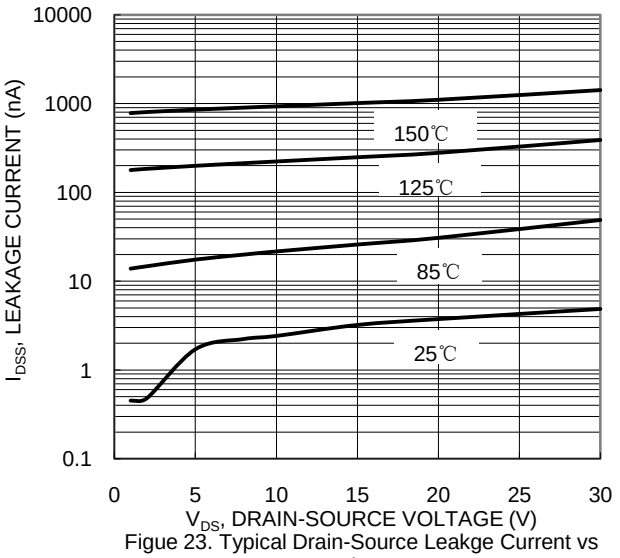


Figure 22. Diode Forward Voltage vs Current



Figue 23. Typical Drain-Source Leakge Current vs Voltage

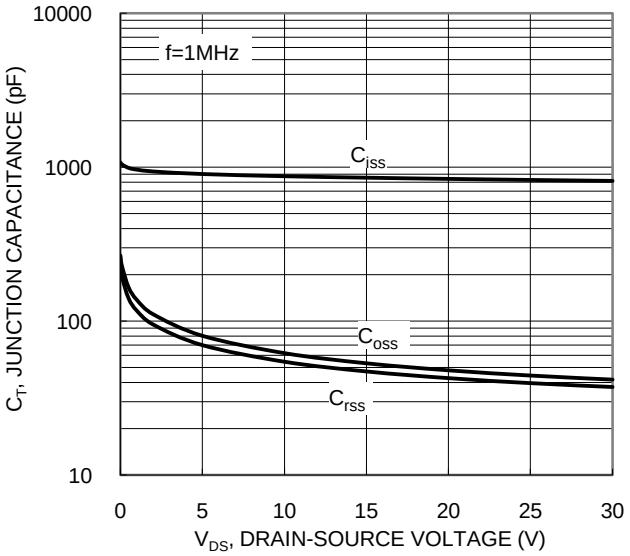


Figure 24. Typical Junction Capacitance

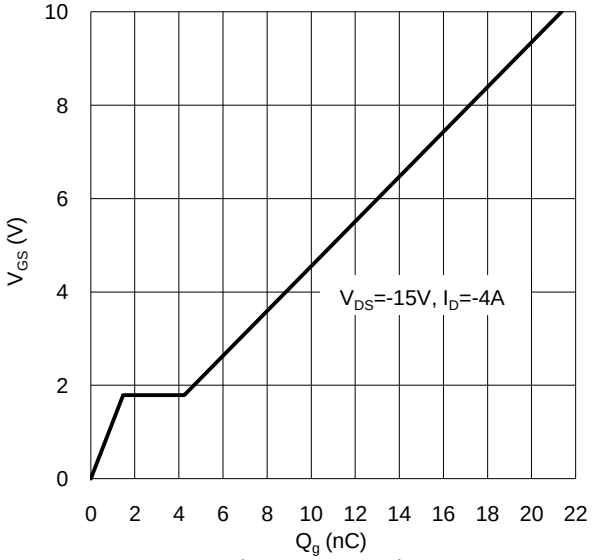


Figure 25. Gate Charge

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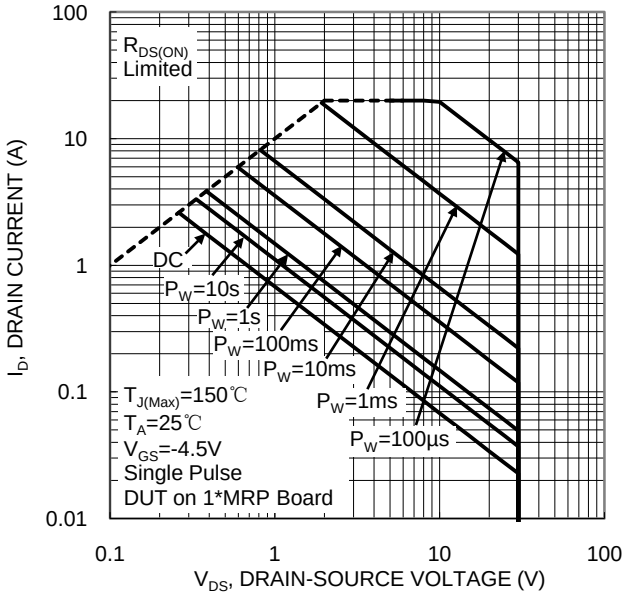
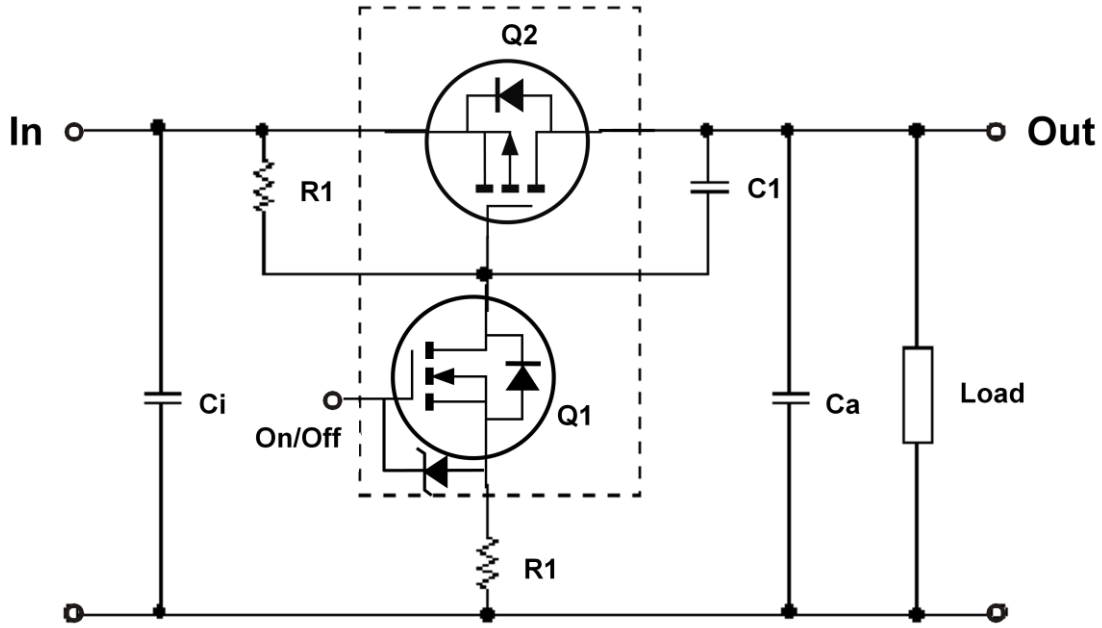


Figure 26. SOA, Safe Operation Area

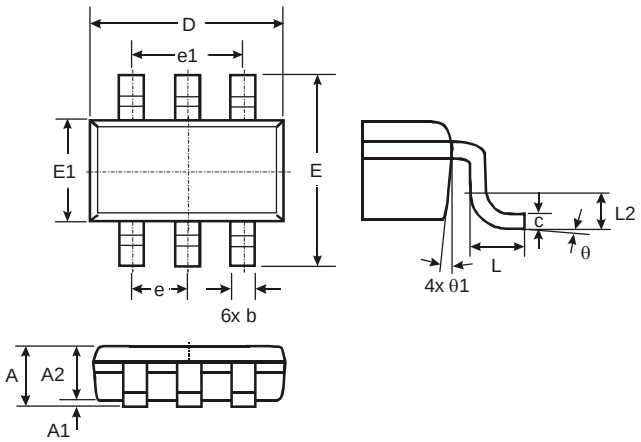
Application Circuit



NEW PRODUCT

Package Outline Dimensions

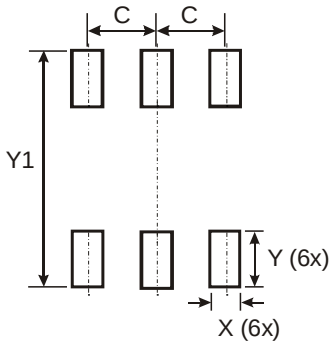
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.



TSOT26			
Dim	Min	Max	Typ
A	–	1.00	–
A1	0.01	0.10	–
A2	0.84	0.90	–
D	–	–	2.90
E	–	–	2.80
E1	–	–	1.60
b	0.30	0.45	–
c	0.12	0.20	–
e	–	–	0.95
e1	–	–	1.90
L	0.30	0.50	
L2	–	–	0.25
θ	0°	8°	4°
θ1	4°	12°	–
All Dimensions in mm			

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
C	0.950
X	0.700
Y	1.000
Y1	3.199

NEW PRODUCT

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LIFE SUPPORT

Diodes Incorporated products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Diodes Incorporated. As used herein:

A. Life support devices or systems are devices or systems which:

1. are intended to implant into the body, or
2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.

B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Customers represent that they have all necessary expertise in the safety and regulatory ramifications of their life support devices or systems, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of Diodes Incorporated products in such safety-critical, life support devices or systems, notwithstanding any devices- or systems-related information or support that may be provided by Diodes Incorporated. Further, Customers must fully indemnify Diodes Incorporated and its representatives against any damages arising out of the use of Diodes Incorporated products in such safety-critical, life support devices or systems.

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